

N-channel 60 V, 3.1 mΩ typ., 80 A STripFET™ F7 Power MOSFET in a DPAK package

Datasheet - production data

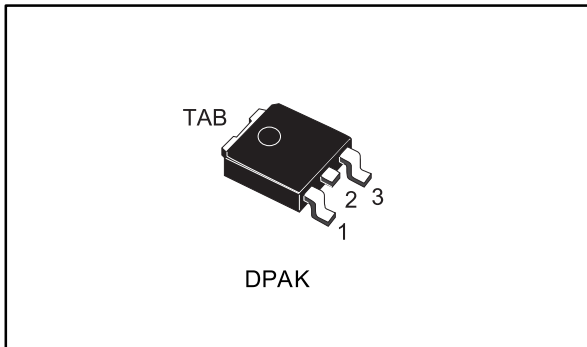
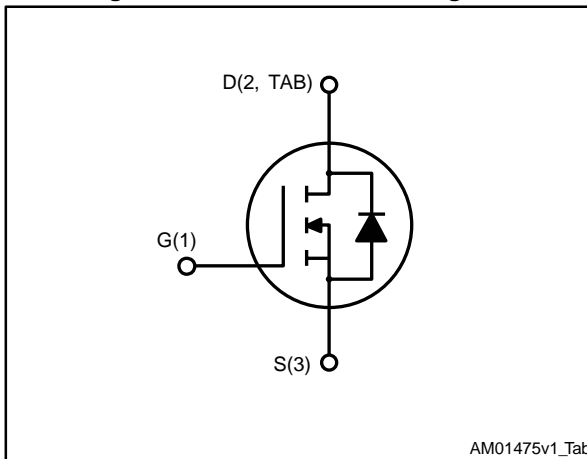


Figure 1: Internal schematic diagram



Features

| Order code | V _{DS} | R _{DS(on)} max. | I _D | P _{TOT} |
|------------|-----------------|--------------------------|----------------|------------------|
| STD140N6F7 | 60 V | 3.8 mΩ | 80 A | 134 W |

- Among the lowest R_{DS(on)} on the market
- Excellent FoM (figure of merit)
- Low C_{rss}/C_{iss} ratio for EMI immunity
- High avalanche ruggedness

Applications

- Switching applications

Description

This N-channel Power MOSFET utilizes STripFET™ F7 technology with an enhanced trench gate structure that results in very low on-state resistance, while also reducing internal capacitance and gate charge for faster and more efficient switching.

Table 1: Device summary

| Order code | Marking | Package | Packing |
|------------|---------|---------|---------------|
| STD140N6F7 | 140N6F7 | DPAK | Tape and reel |

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1 Electrical ratings

Table 2: Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|----------------|--|------------|------|
| V_{DS} | Drain-source voltage | 60 | V |
| V_{GS} | Gate-source voltage | ±20 | V |
| $I_D^{(1)}$ | Drain current (continuous) at $T_{case} = 25\text{ °C}$ | 80 | A |
| | Drain current (continuous) at $T_{case} = 100\text{ °C}$ | 80 | |
| $I_{DM}^{(2)}$ | Drain current (pulsed) | 320 | A |
| P_{TOT} | Total dissipation at $T_{case} = 25\text{ °C}$ | 134 | W |
| $E_{AS}^{(3)}$ | Single pulse avalanche energy | 200 | mJ |
| $dV/dt^{(4)}$ | Drain-body diode dynamic dV/dt ruggedness | 7.1 | V/ns |
| T_{stg} | Storage temperature range | -55 to 175 | °C |
| T_j | Operating junction temperature range | | |

Notes:

- (1) Current is limited by package.
- (2) Pulse width is limited by safe operating area.
- (3) starting $T_j = 25\text{ °C}$, $I_D = 20\text{ A}$, $V_{DD} = 30\text{ V}$.
- (4) $I_{SD} = 80\text{ A}$; $di/dt = 600\text{ A}/\mu\text{s}$; $V_{DD} = 48\text{ V}$; $T_j < T_{jmax}$

Table 3: Thermal data

| Symbol | Parameter | Value | Unit |
|---------------------|----------------------------------|-------|------|
| $R_{thj-pcb}^{(1)}$ | Thermal resistance junction-pcb | 50 | °C/W |
| R_{thj-c} | Thermal resistance junction-case | 1.12 | |

Notes:

- (1) When mounted on FR-4 board of 1 inch², 2oz Cu, $t < 10\text{ sec}$

2 Electrical characteristics

($T_{\text{case}} = 25\text{ °C}$ unless otherwise specified)

Table 4: On/off-states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|-----------------------------------|--|------|------|------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $V_{GS} = 0\text{ V}$, $I_D = 1\text{ mA}$ | 60 | | | V |
| I_{DSS} | Zero gate voltage drain current | $V_{GS} = 0\text{ V}$, $V_{DS} = 60\text{ V}$ | | | 1 | μA |
| I_{GSS} | Gate-body leakage current | $V_{DS} = 0\text{ V}$, $V_{GS} = 20\text{ V}$ | | | 100 | nA |
| $V_{GS(th)}$ | Gate threshold voltage | $V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$ | 2 | | 4 | V |
| $R_{DS(on)}$ | Static drain-source on-resistance | $V_{GS} = 10\text{ V}$, $I_D = 40\text{ A}$ | | 3.1 | 3.8 | m Ω |

Table 5: Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|---|------|------|------|------|
| C_{iss} | Input capacitance | $V_{DS} = 30\text{ V}$, $f = 1\text{ MHz}$, $V_{GS} = 0\text{ V}$ | - | 3100 | - | pF |
| C_{oss} | Output capacitance | | - | 1520 | - | |
| C_{rss} | Reverse transfer capacitance | | - | 193 | - | |
| Q_g | Total gate charge | $V_{DD} = 30\text{ V}$, $I_D = 80\text{ A}$, $V_{GS} = 10\text{ V}$ (see Figure 14: "Test circuit for gate charge behavior") | - | 55 | - | nC |
| Q_{gs} | Gate-source charge | | - | 19 | - | |
| Q_{gd} | Gate-drain charge | | - | 18 | - | |

Table 6: Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--------------|---------------------|--|------|------|------|------|
| $t_{d(on)}$ | Turn-on delay time | $V_{DD} = 30\text{ V}$, $I_D = 40\text{ A}$, $R_G = 4.7\text{ }\Omega$, $V_{GS} = 10\text{ V}$ (see Figure 13: "Test circuit for resistive load switching times") | - | 24 | - | ns |
| t_r | Rise time | | - | 68 | - | |
| $t_{d(off)}$ | Turn-off delay time | | - | 39 | - | |
| t_f | Fall time | | - | 20 | - | |

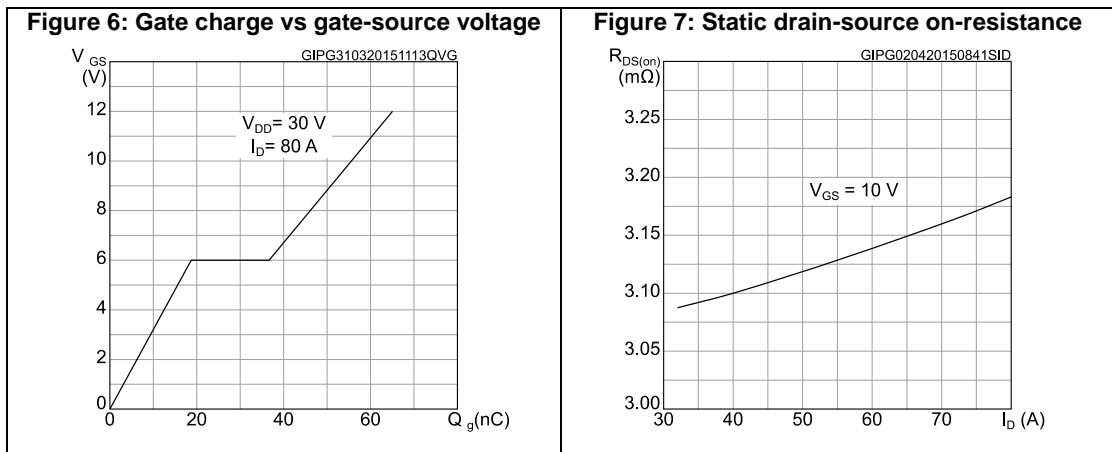
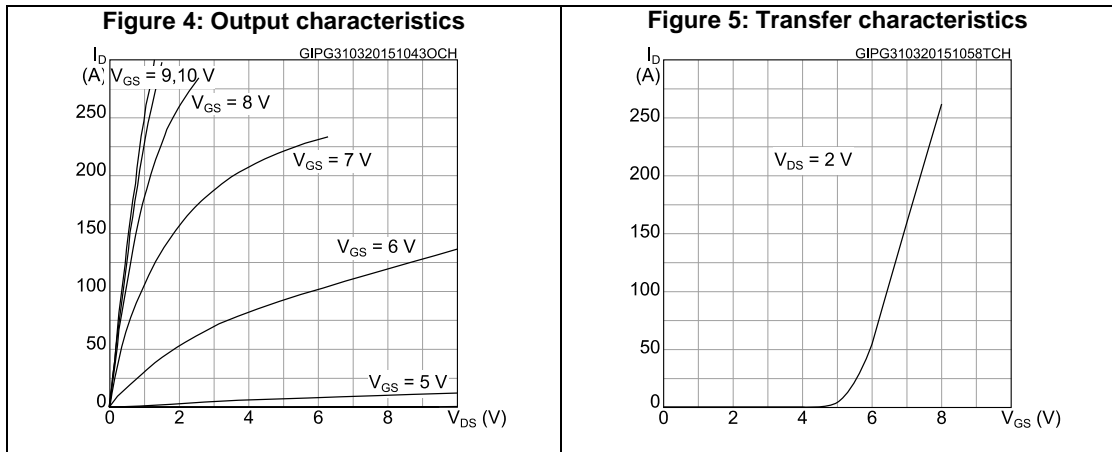
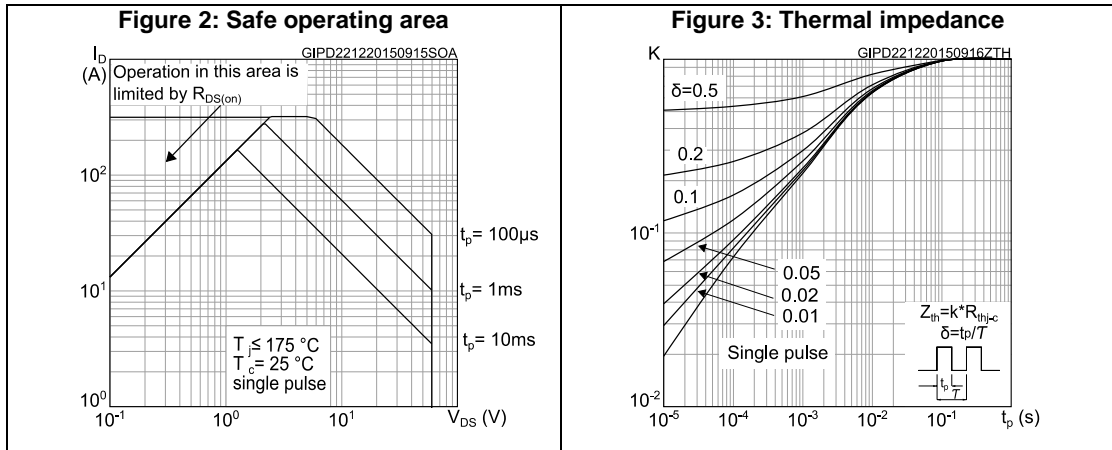
Table 7: Source-drain diode

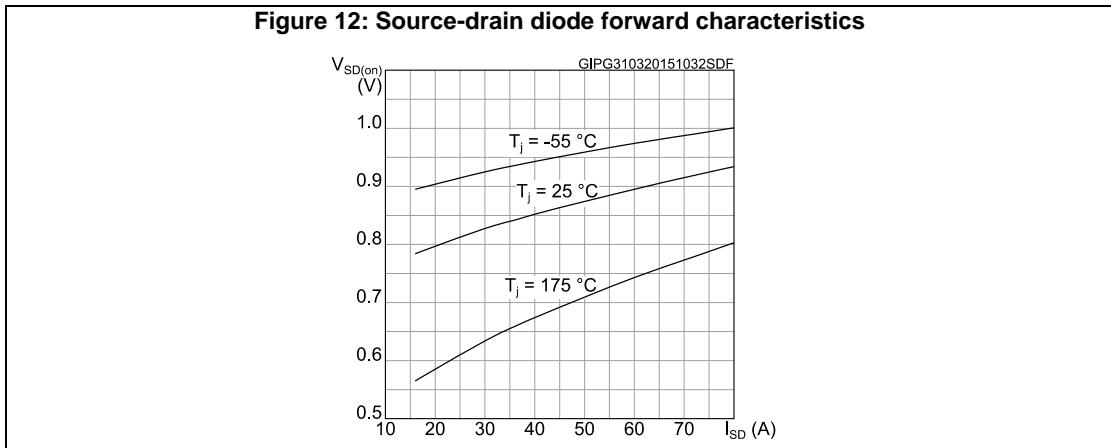
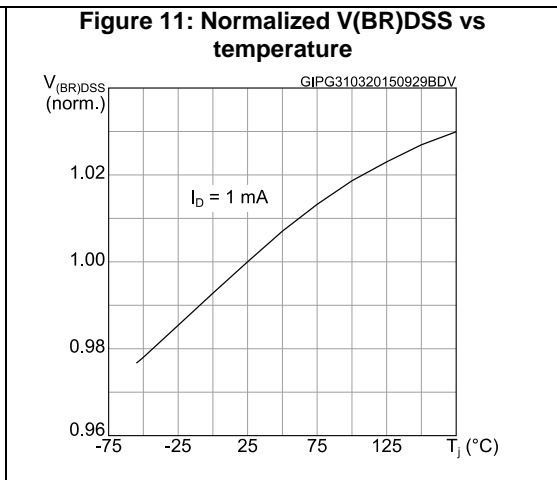
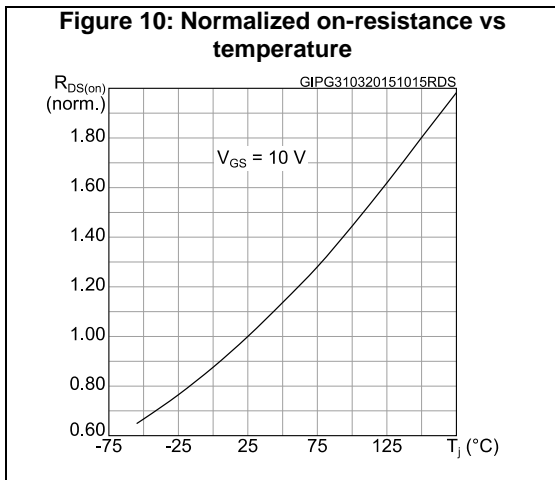
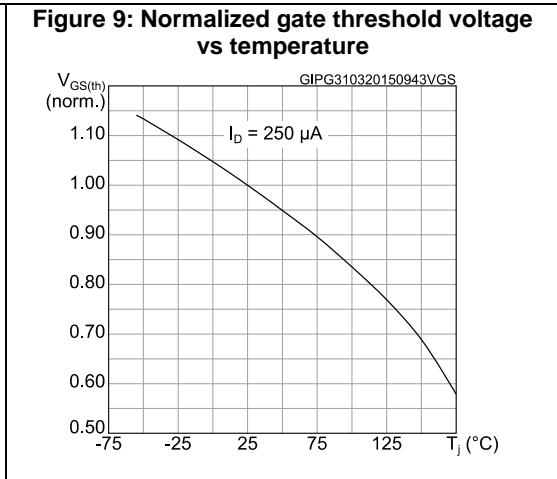
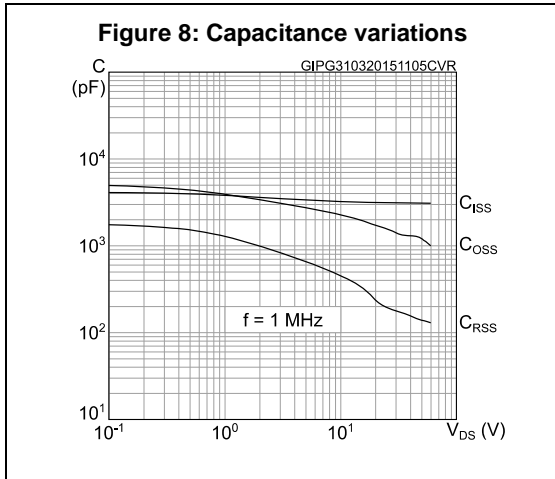
| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------|--------------------------|---|------|------|------|------|
| $V_{SD}^{(1)}$ | Forward on voltage | $V_{GS} = 0\text{ V}$, $I_{SD} = 80\text{ A}$ | - | | 1.2 | V |
| t_{rr} | Reverse recovery time | $I_{SD} = 80\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $V_{DD} = 48\text{ V}$ (see Figure 15: "Test circuit for inductive load switching and diode recovery times") | - | 42.4 | | ns |
| Q_{rr} | Reverse recovery charge | | - | 36.2 | | nC |
| I_{RRM} | Reverse recovery current | | - | 1.8 | | A |

Notes:

(1) Pulse test: pulse duration = 300 μs , duty cycle 1.5%.

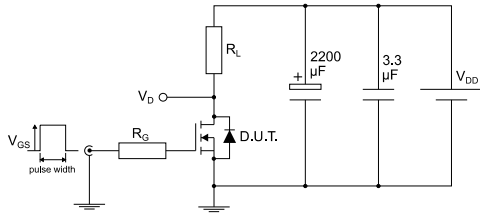
2.1 Electrical characteristics (curves)





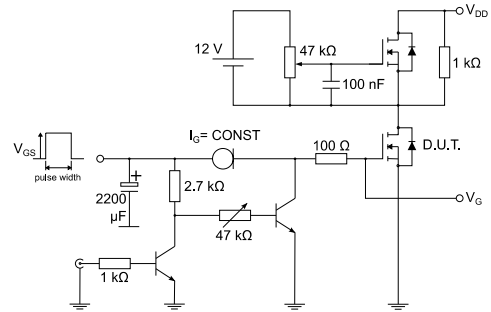
3 Test circuits

Figure 13: Test circuit for resistive load switching times



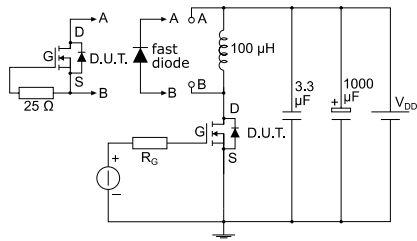
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Figure 14: Test circuit for gate charge behavior



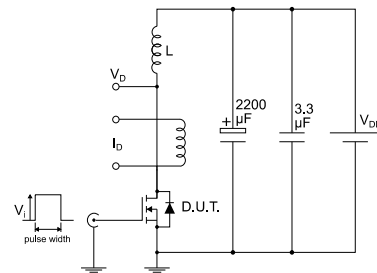
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Figure 15: Test circuit for inductive load switching and diode recovery times



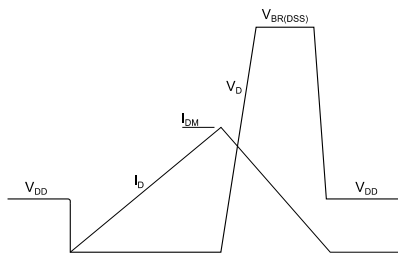
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Figure 16: Unclamped inductive load test circuit



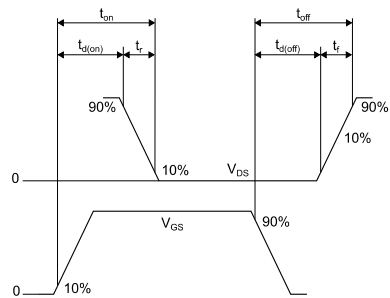
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Figure 17: Unclamped inductive waveform



AM01472v1

Figure 18: Switching time waveform



AM01473v1

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

4.1 DPAK package information

Figure 19: DPAK (TO-252) type A2 package outline

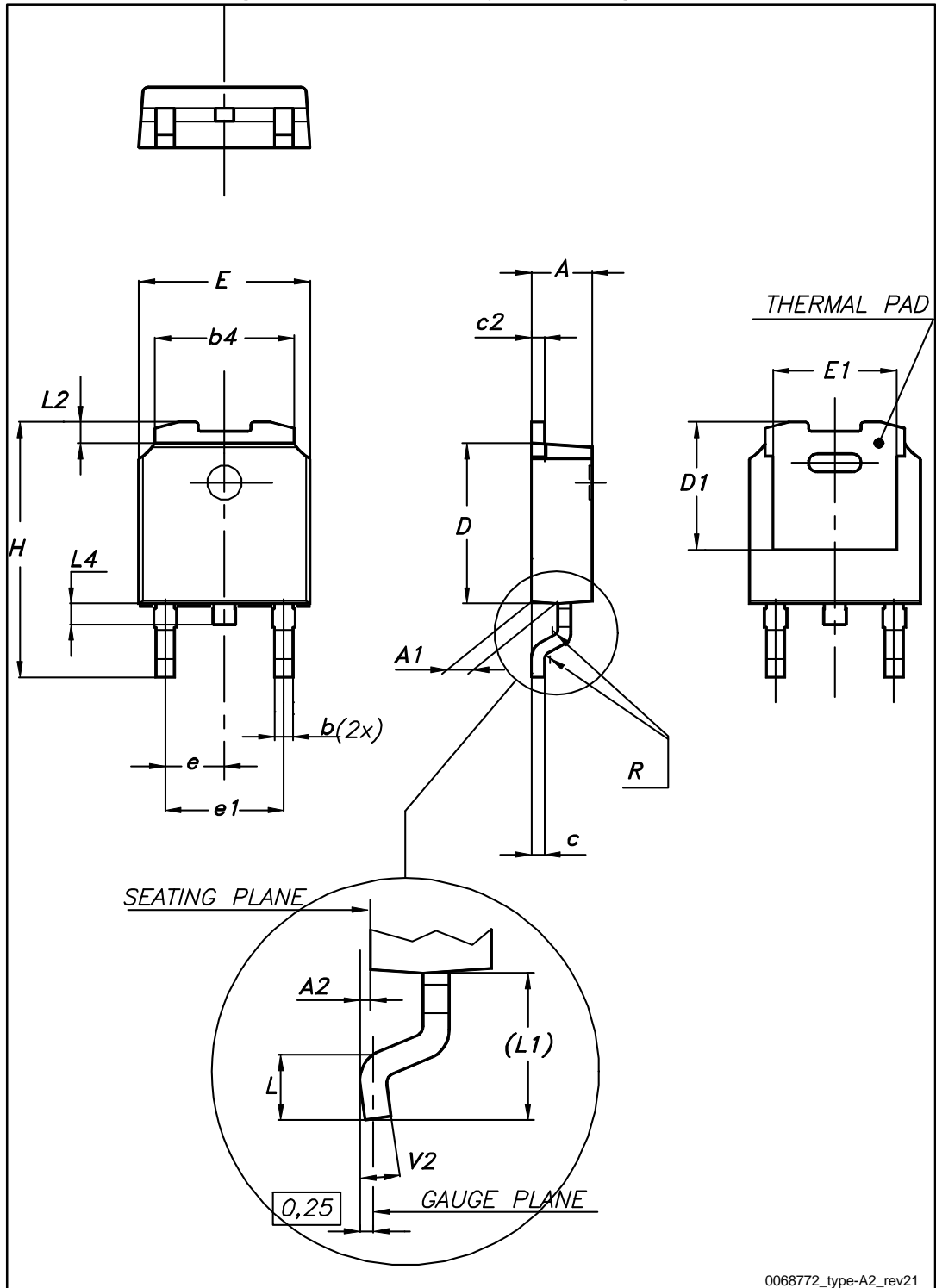
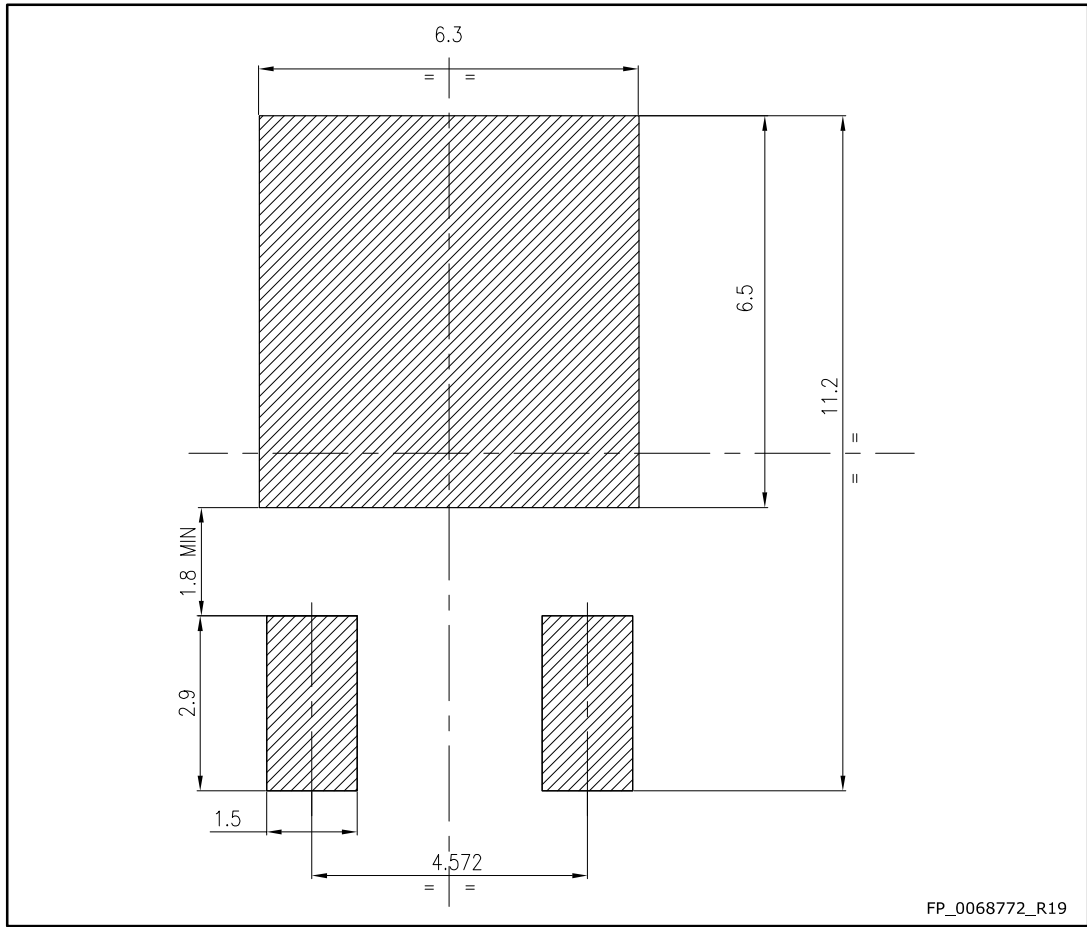


Table 8: DPAK (TO-252) type A2 mechanical data

| Dim. | mm | | |
|------|------|------|-------|
| | Min. | Typ. | Max. |
| A | 2.20 | | 2.40 |
| A1 | 0.90 | | 1.10 |
| A2 | 0.03 | | 0.23 |
| b | 0.64 | | 0.90 |
| b4 | 5.20 | | 5.40 |
| c | 0.45 | | 0.60 |
| c2 | 0.48 | | 0.60 |
| D | 6.00 | | 6.20 |
| D1 | 4.95 | 5.10 | 5.25 |
| E | 6.40 | | 6.60 |
| E1 | 5.10 | 5.20 | 5.30 |
| e | 2.16 | 2.28 | 2.40 |
| e1 | 4.40 | | 4.60 |
| H | 9.35 | | 10.10 |
| L | 1.00 | | 1.50 |
| L1 | 2.60 | 2.80 | 3.00 |
| L2 | 0.65 | 0.80 | 0.95 |
| L4 | 0.60 | | 1.00 |
| R | | 0.20 | |
| V2 | 0° | | 8° |

Figure 20: DPAK (TO-252) recommended footprint (dimensions are in mm)



5 Revision history

Table 9: Document revision history

| Date | Revision | Changes |
|-------------|----------|---|
| 21-Dec-2015 | 1 | First release. |
| 01-Apr-2016 | 2 | Datasheet promoted from preliminary data to production data. Minor text changes. |

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